

VEPIONEER®

Hyperspectral Vision System

FAST, COMPREHENSIVE AND NON-DESTRUCTIVE

VEpioneer[®] is the world's first fully integrated one-button bench-top Hyperspectral Vision system for macro inspection. It captures surface properties, detects thin films and identifies deviations from production specifications.

- FAST Measurement time: 20 seconds
- **COMPREHENSIVE** One run: 100% sample information
- NON-DESTRUCTIVE
 Unique combination of optical spectroscopy and imaging



INSIGHTS FROM INSPECTION

VEpioneer[®] boosts your product and sample knowledge by orders of magnitude with spatially resolved recognition of:

- LAYER THICKNESS
 1 nm 500 μm, depending on layer material
- QUALITY CRITERIA

Defects, contaminations, processing status, roughness of surfaces and interfaces

• SAMPLE PROPERTIES Chemical, electrical, optical

CHECK OUT MORE





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VEPIONEER®

Hyperspectral Vision System

INSPECTED MATERIALS

VEpioneer[®] is designed for simple and fast area measurement of surfaces and thin layers on various substrates:

• SUBSTRATES

Metals, glass, polymers and foils, semiconductors (Si, SiC), ceramics, ...

LAYERS

Oxides, nitrides, carbides, polymers, ...

SPECIFICATIONS

Imaging technique	Pushbroom scanning mode
Measurement mode	Reflectance fluorescence optional
Measurement time (typical)	20 s (@framerate 50 Hz)
Wavelength range	VNIR: 400-1000 nm SWIR 1: 900 – 1700 nm SWIR 2: 1000 – 2500 nm on request
Spectral bands	VNIR: 448 SWIR: 224
Spectral resolution	VNIR: 1.34 nm SWIR: 3.5 nm
Field of view (FOV)	300 mm 200 mm optional
Spatial resolution	VNIR: 300 μm SWIR: 470 μm
	field of view configurable 200 – 300 mm further scan modes with high-resolution available
Lighting	VEluminise unit: tuneable halogen broadband source for homogeneous light field
	broadband LED with spectral range 400 – 900 nm or UV-LED excitation optional
Dimensions	1052 x 568 x 592 mm (L x W x H)
Sample size	360 x 360 mm maximum sample height max. 10 mm,
	further sample sizes optional
Sample stage	Linear, 450 mm travel range, sample holder adapted to customer specifications
Reference	Built-in PTFE protected aluminium optional
Operating conditions	+5 +45 °C (non-condensing)
System weight	90 kg
System certification	CE, RoHS, UKCA
Power requirements	Rated voltage: 230 VAC (115 V optional) Rated frequency: 50 - 60 Hz Rated power: 170 W
Connectivity	RJ45 (ethernet)
Compute unit	Laptop or PC with DIVE VEsolve® Pro software

CHECK OU MORE





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DIMENSIONS

DIVE





Additional configurations regarding sample size and sample stage, optical configurations as well as other specifications can be customised.

CHECK OUT MORF





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